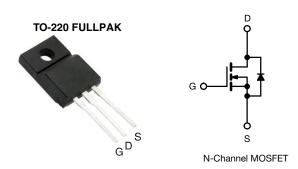
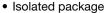
Vishay Siliconix

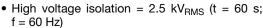
Power MOSFET



PRODUCT SUMMARY					
V _{DS} (V)	200				
R _{DS(on)} (Ω)	V _{GS} = 5.0 V 0.18				
Q _g (Max.) (nC)	66				
Q _{gs} (nC)	9.0				
Q _{gd} (nC)	38				
Configuration	Single				

FEATURES







- Sink to lead creepage distance = 4.8 mm
- Logic-level gate drive
- R_{DS(on)} specified at V_{GS} = 4 V and 5 V
- Fast switching
- · Ease of paralleling
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

DESCRIPTION

Third generation power MOSFETs from Vishay provides the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free	IRLI640GPbF

ABSOLUTE MAXIMUM RATINGS T _C : PARAMETER			SYMBOL	LIMIT	UNIT
Drain-source voltage			V _{DS}	200	
Gate-source voltage			V _{GS}	± 10	V
Outline and deliver west	V -1.5.0.V	T _C = 25 °C		9.9	
Continuous drain current	V _{GS} at 5.0 V	T _C = 100 °C	I _D	6.3	Α
Pulsed drain current ^a			I _{DM}	40	
Linear derating factor				0.32	W/°C
Single pulse avalanche energy b			E _{AS}	290	mJ
Repetitive avalanche current a			I _{AR}	9.9	Α
Repetitive avalanche energy a			E _{AR}	4.0	mJ
Maximum power dissipation $T_C = 25 ^{\circ}C$			P _D	40	W
Peak diode recovery dV/dt c			dV/dt	5.0	V/ns
Operating junction and storage temperature range			T _J , T _{stg}	-55 to +150	°C
Soldering recommendations (peak temperature) ^d	recommendations (peak temperature) d For 10 s			300	
Mauring towns	6-32 or M3 screw			10	lbf ⋅ in
Mounting torque				1.1	N·m

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. V_{DD} = 25 V, starting T_J = 25 °C, L = 4.4 mH, R_G = 25 Ω , I_{AS} = 9.9 A (see fig. 12)
- c. $I_{SD} \le 17$ A, $dI/dt \le 150$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C
- d. 1.6 mm from case

S21-0473-Rev. B, 17-May-2021



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THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum junction-to-ambient	R _{thJA}	-	65	°C/W
Maximum junction-to-case (drain)	R _{thJC}	-	3.1	C/VV

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-ssource breakdown voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 250 μA	200	-	-	V
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = 1 mA		-	0.27	-	V/°C
Gate-source threshold voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	1.0	-	2.0	V
Gate-source leakage	I _{GSS}	,	V _{GS} = ± 10 V	-	-	± 100	nA
7		V _{DS} = 200 V, V _{GS} = 0 V		-	-	25	
Zero gate voltage drain current	I _{DSS}	V _{DS} = 160 V	/, V _{GS} = 0 V, T _J = 160 °C	-	-	250	μA
Duning and a state and a state and a	D	V _{GS} = 5.0 V	I _D = 5.9 A ^b	-	-	0.18	
Drain-source on-state resistance	$R_{DS(on)}$	V _{GS} = 4.0 V	I _D = 5.0 A ^b	-	-	0.27	Ω
Forward transconductance	9 _{fs}	V _{DS} :	= 50 V, I _D = 10 A ^b	16	-	-	S
Dynamic		·		•			
Input capacitance	C _{iss}		V _{GS} = 0 V,	-	1800	-	
Output capacitance	C _{oss}	1	$V_{DS} = 25 \text{ V},$	-	400	-	pF
Reverse transfer capacitance	C _{rss}	f = 1.	.0 MHz, see fig. 5	-	120	-	
Total gate charge	Qg			-	-	66	
Gate-source charge	Q _{gs}	V _{GS} = 10 V	$I_D = 17 \text{ A}, V_{DS} = 160 \text{ V},$ see fig. 6 and 13 ^b	-	-	9.0	nC
Gate-drain charge	Q_{gd}		See lig. 6 and 16	-	-	38	1
Turn-on delay time	t _{d(on)}		1	-	8.0	-	
Rise time	t _r	$V_{DD} = 100 \text{ V}, I_D = 17 \text{ A},$ $R_G = 4.6 \Omega, R_D = 5.7 \Omega,$		-	83	-	
Turn-off delay time	t _{d(off)}			-	44	-	ns -
Fall time	t _f	1	gee lig. 10		52	-	
Internal drain inductance	L _D	Between lead, 6 mm (0.25") from		-	4.5	-	
Internal source inductance	L _S	package and die cont		-	7.5	-	nH
Drain-Source Body Diode Characteristic	cs	1		•	l		
Continuous source-drain diode current	I _S	MOSFET sym showing the		-	-	9.9	A
Pulsed diode forward current ^a	I _{SM}	integral reverse p - n junction diode		-	_	40	
Body diode voltage	V_{SD}	$T_J = 25$ °C, $I_S = 9.9$ A, $V_{GS} = 0$ V b		-	-	2.0	V
Body diode reverse recovery time	t _{rr}	$T_J = 25 ^{\circ}\text{C}$, $I_F = 17 \text{A}$, $dI/dt = 100 \text{A/}\mu\text{s}^{\text{b}}$		-	310	470	ns
Body diode reverse recovery charge	Q _{rr}	1) = 20 C, I _F	= 17 A, al/at = 100 A/µS	-	3.2	4.8	μC
Forward turn-on time	t _{on}	Intrinsic tu	ırn-on time is negligible (turn	-on is dor	ninated b	y L _S and	L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

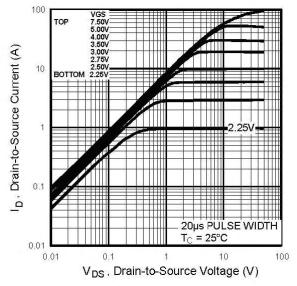


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

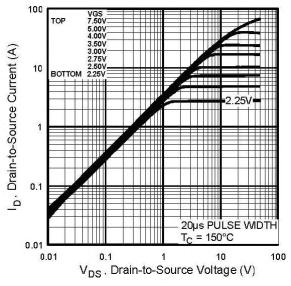


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

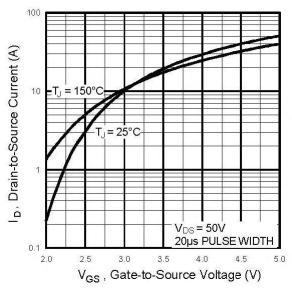


Fig. 3 - Typical Transfer Characteristics

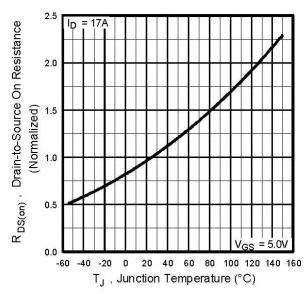


Fig. 4 - Normalized On-Resistance vs. Temperature



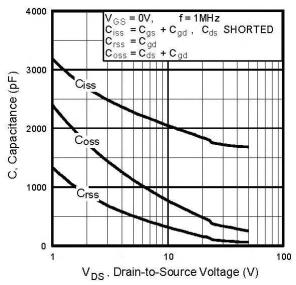


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

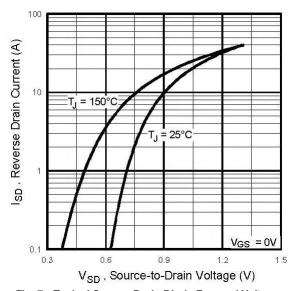


Fig. 7 - Typical Source-Drain Diode Forward Voltage

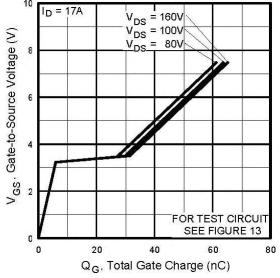


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

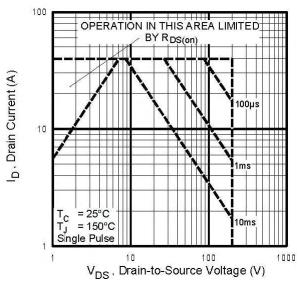


Fig. 8 - Maximum Safe Operating Area



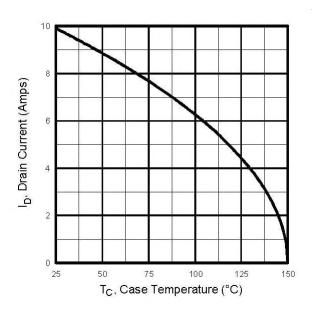


Fig. 9 - Maximum Drain Current vs. Case Temperature

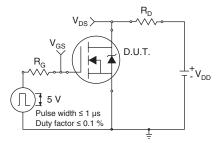


Fig. 10a - Switching Time Test Circuit

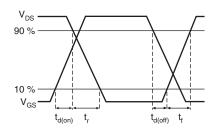


Fig. 10b - Switching Time Waveforms

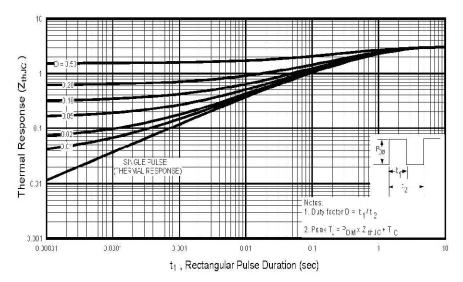


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



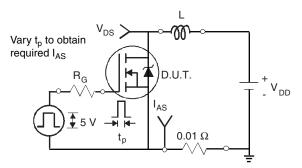


Fig. 12a - Unclamped Inductive Test Circuit

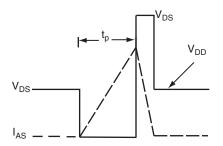


Fig. 12b - Unclamped Inductive Waveforms

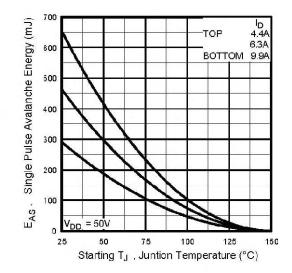


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

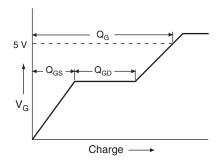


Fig. 13a - Basic Gate Charge Waveform

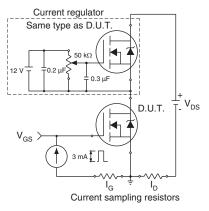
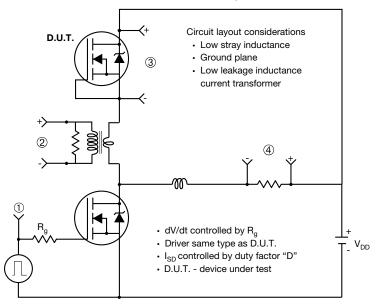


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



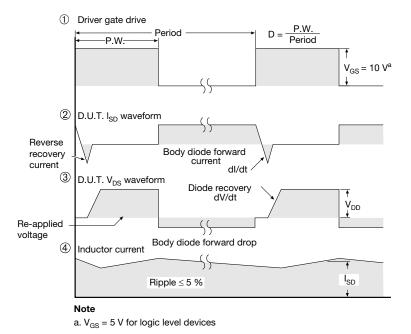


Fig. 14 - For N-Channel

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Vishay Siliconix

TO-220 FULLPAK (High Voltage)

OPTION 1: FACILITY CODE = 9



		MILLIMETERS	
DIM.	MIN.	NOM.	MAX.
Α	4.60	4.70	4.80
b	0.70	0.80	0.91
b1	1.20	1.30	1.47
b2	1.10	1.20	1.30
С	0.45	0.50	0.63
D	15.80	15.87	15.97
е		2.54 BSC	
E	10.00	10.10	10.30
F	2.44	2.54	2.64
G	6.50	6.70	6.90
L	12.90	13.10	13.30
L1	3.13	3.23	3.33
Q	2.65	2.75	2.85
Q1	3.20	3.30	3.40
ØR	3.08	3.18	3.28

Notes

- 1. To be used only for process drawing
- 2. These dimensions apply to all TO-220 FULLPAK leadframe versions 3 leads
- 3. All critical dimensions should C meet $C_{pk} > 1.33$
- 4. All dimensions include burrs and plating thickness
- 5. No chipping or package damage
- 6. Facility code will be the 1st character located at the 2nd row of the unit marking



OPTION 2: FACILITY CODE = Y



	MILLIM	MILLIMETERS		ES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.570	4.830	0.180	0.190
A1	2.570	2.830	0.101	0.111
A2	2.510	2.850	0.099	0.112
b	0.622	0.890	0.024	0.035
b2	1.229	1.400	0.048	0.055
b3	1.229	1.400	0.048	0.055
С	0.440	0.629	0.017	0.025
D	8.650	9.800	0.341	0.386
d1	15.88	16.120	0.622	0.635
d3	12.300	12.920	0.484	0.509
Е	10.360	10.630	0.408	0.419
е	2.54	BSC	0.100 BSC	
L	13.200	13.730	0.520	0.541
L1	3.100	3.500	0.122	0.138
n	6.050	6.150	0.238	0.242
ØΡ	3.050	3.450	0.120	0.136
u	2.400	2.500	0.094	0.098
V	0.400	0.500	0.016	0.020

ECN: E19-0180-Rev. D, 08-Apr-2019

DWG: 5972

Notes

- 1. To be used only for process drawing
- 2. These dimensions apply to all TO-220 FULLPAK leadframe versions 3 leads
- 3. All critical dimensions should C meet $C_{pk} > 1.33$
- 4. All dimensions include burrs and plating thickness
- 5. No chipping or package damage
- 6. Facility code will be the 1st character located at the 2nd row of the unit marking



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Vishay

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